

SPECIFICATIONS

Customer	
Product Name	Chip NTC Thermistor
Sunlord Part Number	SDNT1608X103F3435FTF
Customer Part Number	

New Released, Revised] **SPEC No.:** SDNT10190000

【This SPEC is total 10 pages including specifications and appendix.】

【ROHS Compliant Parts】

Approved By	Checked By	Issued By

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【For Customer approval Only】

Date: _____

Qualification Status: Full Restricted Rejected

Approved By	Verified By	Re-checked By	Checked By

Comments:

【Version change history】

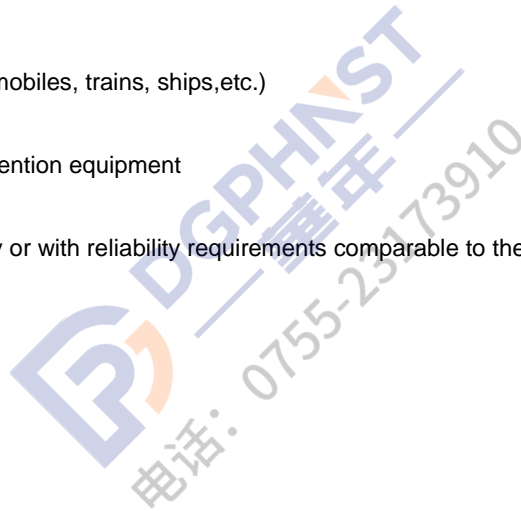
Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	/	New release	/	Xiangdong Zeng

 DGP HNST
— 華年 —
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Caution

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

1. Aircraft equipment
2. Aerospace equipment
3. Undersea equipment
4. nuclear control equipment
5. military equipment
6. Power plant equipment
7. Medical equipment
8. Transportation equipment (automobiles, trains, ships, etc.)
9. Traffic signal equipment
10. Disaster prevention / crime prevention equipment
11. Data-processing equipment
12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above



1. Scope

This specification applies to SDNT1608X103F3435FTF of chip NTC thermistors.

2. Product Description and Identification (Part Number)

1) Description

Example:

SDNT1608X103F3435FTF of multi-layer chip NTC thermistors.

2) Product Identification (Part Number)

SDNT 1608 X 103 F 3435 F I F
 ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨

①	Type
SDNT	Chip NTC Thermistor

②	External Dimensions (LxW) [mm]
1608 [0603]	1.6 × 0.8

③	Internal Code
	X

④	Nominal Zero-Power Resistance (KΩ)
Example	Nominal Value
103	10

⑤	Resistance Tolerance
F	±1%

⑦	B Constant Tolerance
F	±1%

⑥	Nominal B Constant (25°C to 50°C)
Example	Nominal
3435	3435K

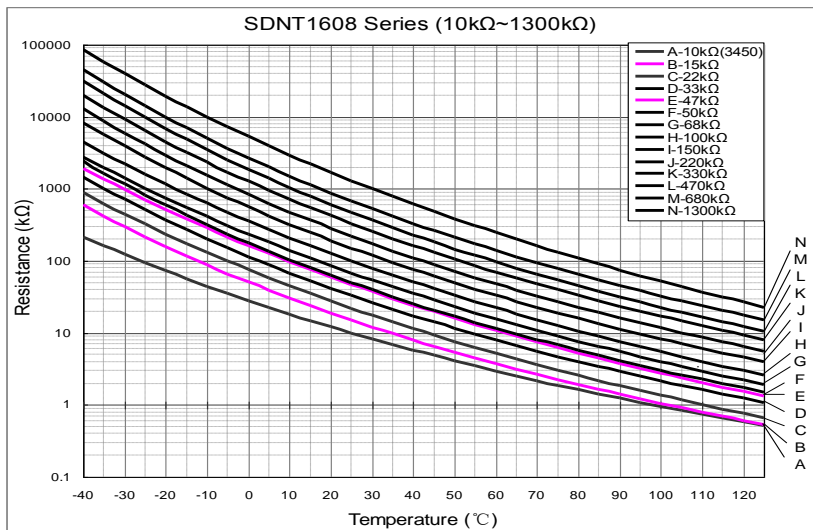
⑨	HSF Products
	Hazardous Substance Free Products

⑧	Packaging
T	Tape & Reel

3. Electrical Characteristics

Part Number	Resistance at 25°C R25 (kΩ)	B constant (25-50°C) (K)	Max. Permissible Operating Current (25°C) (mA)	Thermal Time Constant	Dissipation Factor (mW/°C)	Rated Electric Power (mW)
SDNT1608X103F3435FTF	10	3435	0.31	<5sec	1.0	100

TYPICAL ELECTRICAL CHARACTERISTICS



- 1) Operating and storage temperature range (individual chip without packing): -55°C ~ +125°C
- 2) Storage temperature range (packing conditions): -10°C~+40°C and RH 75% (Max.)

4. Shape and Dimensions

- 1) Dimensions: See Fig.4-1 and Table 4-1.
- 2) Recommended PCB pattern for reflow soldering: See Fig.4-2 and Table 4-1.

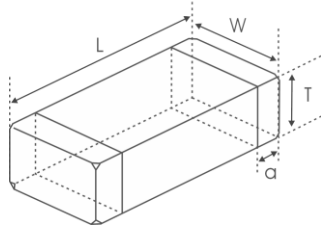


Fig. 4-1

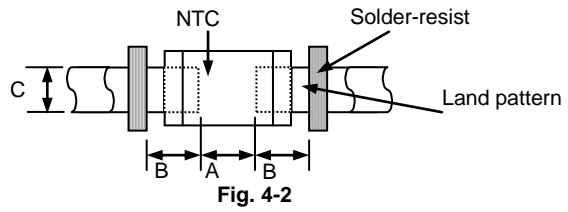


Fig. 4-2

[Table 4-1]

Unit: mm [inch]

Type	L	W	T	a	A	B	C
1608 [0603]	1.6±0.15 [0.063±0.006]	0.8±0.15 [0.031±0.006]	0.8±0.15 [0.031±0.006]	0.3±0.2 [0.012±0.008]	0.60~0.80	0.60~0.80	0.60~0.80



5. Test and Measurement Procedures

5.1 Test Conditions

5.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a. Ambient Temperature: 20±15°C
- b. Relative Humidity : 65±20%
- c. Air Pressure: 86kPa to 106kPa

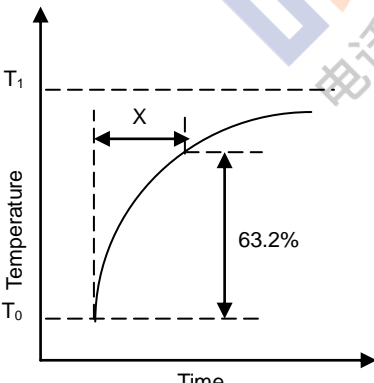
5.1.2 If any doubt on the results, measurements/tests should be made within the following limits:

- a. Ambient Temperature: 20±2°C
- b. Relative Humidity: 65±5%
- c. Air Pressure: 86kPa to 106kPa

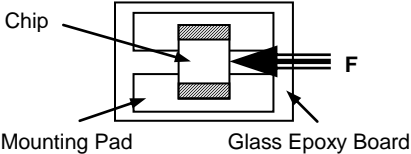
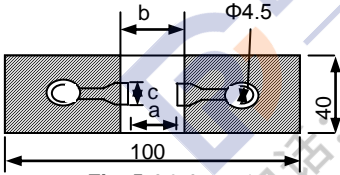
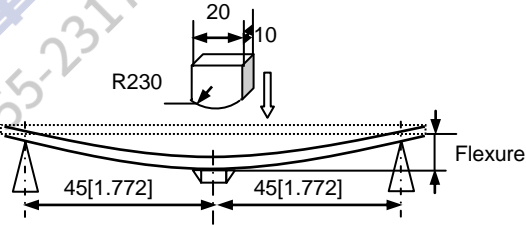
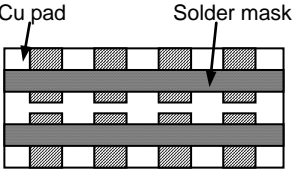
5.2 Visual Examination

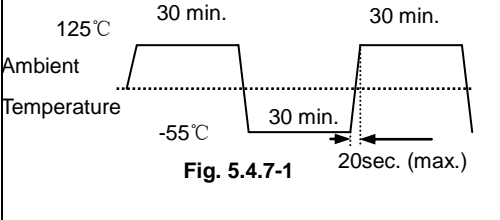
- a. Inspection Equipment: 20× magnifier

5.3 Electrical Test

Items	Requirements	Test Methods and Remarks
5.3.1 Nominal Zero-Power Resistance (R25)	Refer to Item 3.	Ambient temperature: 25±0.2°C. Measuring electric power: 0.1mW Max.
5.3.2 Nominal B Constant	Refer to Item 3.	Measure the resistance at the ambient temperature of 25±0.2°C and 50±0.2°C $B = \frac{\ln R_{25} - \ln R_{50}}{1/T_{25} - 1/T_{50}}$ T: absolute temperature (K)
5.3.3 Thermal Time Constant (single unit)	Refer to Item 3. 	The total time for the temperature of the thermistor to change by 63.2% of the difference from ambient temperature T ₀ (°C) to T ₁ (°C) by the drastic change of the power applied to thermistor from Non-zero Power to Zero-Power state.
5.3.4 Dissipation Constant (single unit)	Refer to Item 3.	The total electric power required to raise the temperature of the element by 1°C through self-heating under thermal equilibrium. It calculates by next formula. $C = \frac{W}{T - T_0}$
5.3.5 Rated Power	Refer to Item 3.	The necessary electric power makes thermistor's temperature rise 100°C by self-heating at ambient temperature 25°C.
5.3.6 Permissive operating current	Refer to Item 3.	The current that keeps body temperature of chip NTC on the PC board in still air rising 1°C by self-heating.

5.4 Reliability Test

Items	Requirements	Test Methods and Remarks								
5.4.1. Terminal Strength	No removal or split of the termination or other defects shall occur.  Fig.5.4.1-1	<ol style="list-style-type: none"> Solder the chip to the testing jig (glass epoxy board shown in the following Fig. 5.4.1-1) using eutectic solder. Then apply a force in the direction of the arrow. 5N force for 1608 series. Keep time: 10±1s. 								
5.4.2 Resistance to Flexure	No visible mechanical damage. Unit: mm [inch] <table border="1" data-bbox="308 651 767 741"> <thead> <tr> <th>Type</th> <th>a</th> <th>b</th> <th>c</th> </tr> </thead> <tbody> <tr> <td>1608[0603]</td> <td>1.0</td> <td>3.0</td> <td>1.2</td> </tr> </tbody> </table>  Fig. 5.4.2-1	Type	a	b	c	1608[0603]	1.0	3.0	1.2	<ol style="list-style-type: none"> Solder the chip to the test jig (glass epoxy board shown in Fig. 5.4.2-1) using a eutectic solder. Then apply a force in the direction shown in Fig. 5.4.2-2. Flexure: 2mm. Pressurizing Speed: 0.5mm/sec. Keep time: 30 sec.  Fig. 5.4.2-2
Type	a	b	c							
1608[0603]	1.0	3.0	1.2							
5.4.3 Vibration	No visible mechanical damage.  Glass Epoxy Board Fig. 5.4.3-1	<ol style="list-style-type: none"> Solder the chip to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using eutectic solder. The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency ranging from 10 to 55 Hz and returning to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours). 								
5.4.4 Dropping	<ol style="list-style-type: none"> No visible mechanical damage. 	Drop chip inductor 10 times on a concrete floor from a height of 100 cm.								
5.4.5 Solderability	<ol style="list-style-type: none"> No visible mechanical damage. Wetting shall exceed 80% coverage. 	<ol style="list-style-type: none"> Solder temperature: 240±2°C. Duration: 3 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. 								
5.4.6 Resistance to Soldering Heat	<ol style="list-style-type: none"> No visible mechanical damage. R25 change: within ±1% B Constant change: within ±1% 	<ol style="list-style-type: none"> Solder temperature: 260±3°C Duration: 5 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. The chip shall be stabilized at normal condition for 1~2 hours before measuring. 								

<p>5.4.7 Thermal Shock</p>	<p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$ ③ B Constant change: within $\pm 1\%$</p>  <p>Fig. 5.4.7-1</p>	<p>① Temperature, Time: -55°C for 30 ± 3 min \rightarrow 125°C for 30 ± 3 min. ② Transforming interval: 20sec. Max. ③ Tested cycle: 100 cycles. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>5.4.8 Resistance to Low Temperature</p>	<p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$ ③ B Constant change: within $\pm 1\%$</p>	<p>① Temperature: $-55\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>5.4.9 Resistance to High Temperature</p>	<p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$ ③ B Constant change: within $\pm 1\%$</p>	<p>① Temperature: $125\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>5.4.10 Damp Heat (Steady States)</p>	<p>① No visible mechanical damage. ② R25 change: within $\pm 1\%$ ③ B Constant change: within $\pm 1\%$</p>	<p>① Temperature: $60\pm 2^{\circ}\text{C}$ ② Humidity: 90% to 95% RH. ③ Duration: 1000^{+24} hours. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>
<p>5.4.11 Loading at High Temperature (Life Test)</p>	<p>① No visible mechanical damage. ② R25 change: Within $\pm 1\%$ ③ B constant change: Within $\pm 1\%$</p>	<p>① Temperature: $85\pm 2^{\circ}\text{C}$ ② Duration: 1000^{+24} hours. ③ Applied current: Max. Permissive Operating Current. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p>

6. Packaging, Storage and Transportation

6.1 Packaging

6.1.1 Tape Carrier Packaging:

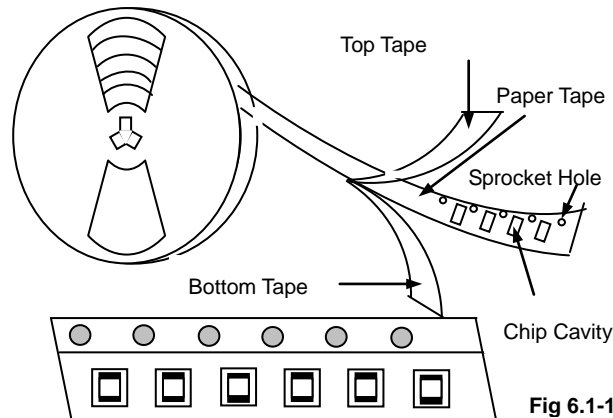
Packaging code: T

a. Tape carrier packaging are specified in attached figure Fig.6.1-1~3

b. Tape carrier packaging quantity please see the following table:

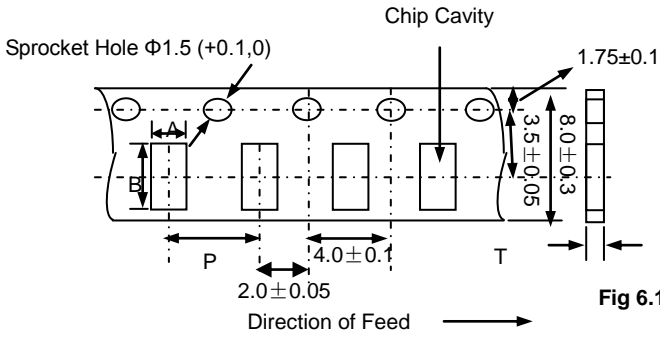
Type	1608[0603]
T(mm)	0.8 ± 0.15
Tape	Paper Tape
Quantity	4K

(1). Taping Drawings (Unit: mm)



Remark: The sprocket holes are to the right as the tape is pulled toward the user.

(2) Taping Dimensions (Unit: mm)



Type	A	B	P	Tmax
1608[0603]	1.0±0.2	1.8±0.2	4.0±0.1	1.1

Fig 6.1-2

(3) Reel Dimensions (Unit: mm)

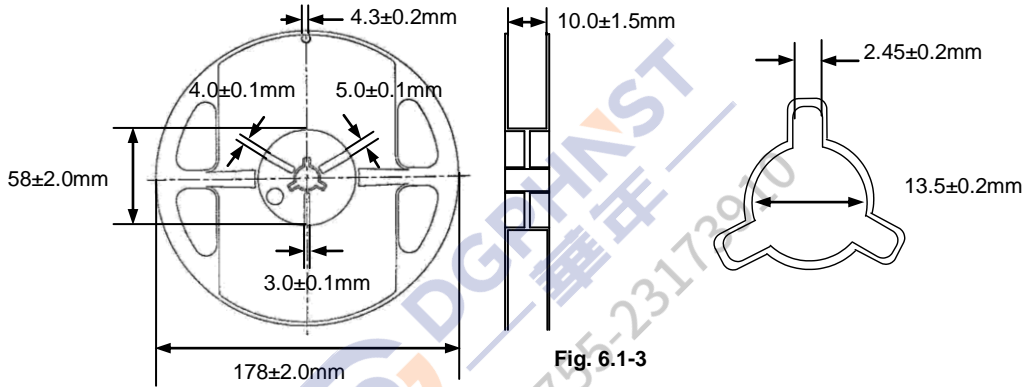


Fig. 6.1-3

6.2 Storage

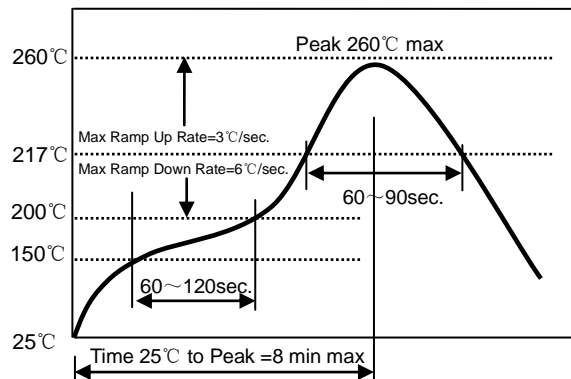
- a. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S)
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Solderability specified in **Clause 5.4.6** shall be guaranteed for 9 months from the date of delivery on condition that they are stored at the environment specified in **Clause 3** .For those parts, which passed more than 9 months shall be checked solder-ability before use.

7. Recommended Soldering Technologies

7.1 Re-flowing Profile:

- △ Preheat condition: 150 ~200°C/60~120sec.
- △ Allowed time above 217°C: 60~90sec.
- △ Max temp: 260°C
- △ Max time at max temp: 10sec.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- △ Allowed Reflow time: 2x max

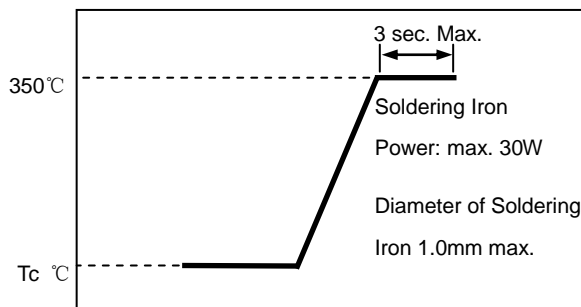
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



7.2 Iron Soldering Profile.

- △ Iron soldering power: Max.30W
- △ Pre-heating: 150 °C / 60 sec.
- △ Soldering Tip temperature: 350°C Max.
- △ Soldering time: 3 sec Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- △ Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



8. Supplier Information

- a) Supplier:
Shenzhen Sunlord Electronics Co., Ltd.
- b) Manufacturer:
Shenzhen Sunlord Electronics Co., Ltd.
- c) Manufacturing Address:
Sunlord Industrial Park, Dafuyuan Industrial Zone, Guanlan, Shenzhen, China
Zip: 518110

